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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/024,724	12/21/2001	Michael D. Haines	219.40853X00	5908	
7590 03/02/2004			EXAMINER		
Kenyon & Kenyon			WILLIAMS, ALEXANDER O		
1500 K. Street 1	N.W.				
Suite 700			ART UNIT	PAPER NUMBER	
Washington, DC 20005			2826		
			DATE MAIL ED: 02/02/200	4	

Please find below and/or attached an Office communication concerning this application or proceeding.

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•		Applicat	Application No. Applicant(s)		•	
Office Action Summer:		10/024,7	724	HAINES, MICHAE	HAINES, MICHAEL D.	
	Office Action Summary	Examine	er	Art Unit	Nal	
			er O Williams	2826	Au	
Period fo	- The MAILING DATE of this commun r Reply	nication appears on th	ie cover sheet wit	h the correspondence ac	ddress	
THE N - Exten after \$ - If the - If NO - Failur Any re	DRTENED STATUTORY PERIOD F MAILING DATE OF THIS COMMUN sions of time may be available under the provisions SIX (6) MONTHS from the mailing date of this come period for reply specified above is less than thirty (i) period for reply is specified above, the maximum is the to reply within the set or extended period for reply typly received by the Office later than three months d patent term adjustment. See 37 CFR 1.704(b).	IICATION. s of 37 CFR 1.136(a). In no e munication. 30) days, a reply within the sta tatutory period will apply and v y will, by statute, cause the ap	vent, however, may a re atutory minimum of thirty will expire SIX (6) MONT optication to become ABA	ply be timely filed (30) days will be considered timel HS from the mailing date of this c INDONED (35 U.S.C. § 133).		
Status						
1)[]	Responsive to communication(s) file	ed on <i>21 October 20</i> 6	03.			
·		2b)⊠ This action is				
3) 🗌	Since this application is in condition	for allowance excep	t for formal matte	rs, prosecution as to the	e merits is	
	closed in accordance with the pract	ice under <i>Ex parte Q</i>	uayle, 1935 C.D.	11, 453 O.G. 213.		
Disposition	on of Claims					
5) [Claim(s) <u>1-30</u> is/are pending in the state of the above claim(s) <u>28 and 29</u> Claim(s) is/are allowed. Claim(s) <u>1-28</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restrict	is/are withdrawn from				
Application	on Papers					
9) 🗌 7	The specification is objected to by th	e Examiner.				
10)[] 7	he drawing(s) filed on is/are	: a)□ accepted or b)□ objected to b	y the Examiner.		
	Applicant may not request that any obje			, ,		
	Replacement drawing sheet(s) including The oath or declaration is objected to		*·	•	• •	
	nder 35 U.S.C. § 119	o by the Examinor. It	· · · · · · · · · · · · · · · · · · ·	Cinice Action of Tomit 1	10-132.	
12)	Acknowledgment is made of a claim All b) Some * c) None of: 1. Certified copies of the priority 2. Certified copies of the priority 3. Copies of the certified copies application from the Internationse the attached detailed Office actions	documents have be documents have be of the priority docum onal Bureau (PCT Ru	en received. en received in Ap ents have been r ele 17.2(a)).	plication No eceived in this National	Stage	
Attachment(s)					
1) Notice	of References Cited (PTO-892) of Draftsperson's Patent Drawing Review (P	2TO 049)	4) Interview Su	mmary (PTO-413) /Mail Date		
3) 🔯 Inform Paper	of Draftsperson's Patent Drawing Review (Fation Disclosure Statement(s) (PTO-1449 or No(s)/Mail Date <u>6</u> .			ormal Patent Application (PTC	O-152)	

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Serial Number: 10/024724 Attorney's Docket #: 219.40853X00

Filing Date: 12/21/01;

Applicant: Haines

Examiner: Alexander Williams

Applicant's election of Group I (claims 1 to 28) in Paper # 14, filed 10/21/03, has been acknowledged.

This application contains claims 29 and 30 drawn to an invention non-elected with traverse in Paper No. 14.

The title of the invention is not descriptive. A new title is required that is clearly indicative of the invention to which the claims are directed.

Claims 11, 20 and 27 are rejected under 35 U.S.C. § 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

In claims 11, 20 and 27, it is unclear and confusing to the structure claimed by the language of "wherein the gasket has a shielding effectiveness to protect the die from at least 4 kV of electrostatic discharge pulse at a system level in which the electronic package is to be used."

Any of claims 11, 20 and 27 not specifically addressed above are rejected as being dependent on one or more of the claims which have been specifically objected to above.

The following is a quotation of the appropriate paragraphs of 35 U.S.C. § 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless --

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

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(e) the invention was described in a patent granted on an application for patent by another filed in the United States before the invention thereof by the applicant for patent, or on an international application by another who has fulfilled the requirements of paragraphs (1), (2), and (4) of section 371(c) of this title before the invention thereof by the applicant for patent.

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 22, 24 and 26 to 28, **insofar as they can be understood**, are rejected under 35 U.S.C. § 102(e) as being anticipated by Morris (U.S. Patent # 6,507,101 B1). 22. Morris (figures 1A to 4B) specifically figure 2 show an electronic package with protection from electrostatic discharge events comprising: a substrate **210**; a semiconductor die **212** mounted on the substrate; a heat sink **206** in heat conducting relation with the semiconductor die on a side of the semiconductor die opposite the substrate; and a gasket of a lossy material **202** on the substrate surrounding the semiconductor die to protect the die form electrostatic discharge pulses.

- 24. The electronic package according to claim 22, Morris show wherein the lossy material of the gasket is a static dissipative material having, a volume resistivity of greater than 102 ohm cm.
- 26. Morris show wherein the gasket **22** has a hole therein the size of the die through which the die protrudes.
- 27. Morris show wherein the gasket has a shielding effectiveness to protect the die from at least 4 kV of electrostatic discharge pulse at a system level in which the electronic package.
- 28. Morris show wherein the gasket material has a shielding effectiveness of greater than 45 dB up to 3 GHz.

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Claims 1, 3 to 8, 11, 12, 22 to 24, 27 and 28, **insofar as they can be understood**, are rejected under 35 U.S.C. § 102(b) as being anticipated by Barker, III et al. (U.S. Patent # 5,175,613).

- 1. Barker, III et al. (figures 1 and 2) specifically figure 2 show an assembly for packaging and cooling a semiconductor die comprising: a substrate 12; a semiconductor die 24 mounted on the substrate; a thermal spreader 52 in heat conducting relation with the semiconductor die on a side of the die opposite the substrate; and a gasket of a lossy material 26 on the substrate surrounding the die to protect the die from electrostatic discharge pulses.
- 3. The assembly according to claim 1, Barker, III et al. further comprising a heat sink **14** in heat conducting relation with the thermal spreader on a side of the thermal spreader opposite the die.
- 4. The assembly according to claim 1, Barker, III et al. show wherein the semiconductor die is a microprocessor.
- 5. The assembly according to claim 1, Barker, III et al. show wherein the lossy material of the gasket is a static dissipative material having a volume resistivity of greater than 10^2 ohm cm.
- 6. The assembly according to claim 5, Barker, III et al. show wherein the volume resistivity of the static dissipative material is less than 10⁹ ohm cm.
- 7. The assembly according to claim 1, Barker, III et al. show wherein the gasket is bonded to the substrate with an adhesive 25.
- 8. The assembly according to claim 7, Barker, III et al. show wherein the adhesive is conductive.
- 11. The assembly according to claim 1, Barker, III et al. show wherein the gasket has a shielding effectiveness to protect the die from at least 4 kV of electrostatic discharge pulse at a system level in which the assembly is to be used.
- 12. The assembly according to claim 1, Barker, III et al. show wherein the gasket material has a shielding effectiveness of greater than 45 dB tip to 3 GHz in frequency. 22. Barker, III et al. (figures 1 and 2) specifically figure 2 show an electronic package with protection from electrostatic discharge events comprising: a substrate 12; a semiconductor die 24 mounted on the substrate; a heat sink 14 in heat conducting relation with the semiconductor die on a side of the semiconductor die opposite the substrate; and a gasket of a lossy material 26 on the substrate surrounding the

semiconductor die to protect the die from electrostatic discharge pulses.

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23. The electronic package according to claim 22, Barker, III et al. show further comprising a thermal spreader located intermediate the semiconductor die and the heat sink to thermally couple the die and heat sink.

- 24. The electronic package according to claim 22, Barker, III et al. show wherein the lossy material of the gasket is a static dissipative material having, a volume resistivity of greater than 10² ohm cm.
- 27. Barker, III et al. show wherein the gasket has a shielding effectiveness to protect the die from at least 4 kV of electrostatic discharge pulse at a system level in which the electronic package.
- 28. Barker, III et al. show wherein the gasket material has a shielding effectiveness of greater than 45 dB up to 3 GHz.

Claims 1 to 8, 10 to 17, 19 to 21 and 23, **insofar as they can be understood**, are rejected under 35 U.S.C. § 103(a) as being unpatentable over Morris (U.S. Patent # 6,507,101 B1) in view of Alcoe et al. (U.S. Patent Application Publication # 2003/0025180 A1).

1. Morris (figures 1A to 4B) specifically figure 2 show an assembly for packaging and cooling a semiconductor die comprising: a substrate **210**; a semiconductor die **212** mounted on the substrate; and a gasket of a lossy material **202** on the substrate surrounding the die to protect the die from electrostatic discharge pulses. Morris fails to explicitly show a thermal spreader in heat conducting relation with the semiconductor die on a side of the die opposite the substrate.

Alcoe et al. is cited for showing an EMI shielding for semiconductor chip carriers. Specifically, Alcoe et al. (figures 1 to 3) specifically figure 2 discloses a thermal spreader (unlabeled electrically-conductive material between the heat sink 48 and chip 42 and substrate 40) in heat conducting relation with the semiconductor die on a side of the die opposite the substrate (see page 3, paragragh [0040]) for the purpose of producing an EMI shield for the structure.

- 2. The assembly according to claim 1, the combination with Alcoe et al. showing wherein the thermal spreader extends beyond the outer peripheral edge of the die and overhangs an adjacent edge of the gasket **52**.
- 3. The assembly according to claim 1, the combination with Alcoe et al. further comprising a heat sink **48** in heat conducting relation with the thermal spreader on a side of the thermal spreader opposite the die **42**.

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4. The assembly according to claim 1, either show wherein the semiconductor die is a microprocessor.

- 5. The assembly according to claim 1, either show wherein the lossy material of the gasket is a static dissipative material having a volume resistivity of greater than 10² ohm cm.
- 6. The assembly according to claim 5, either show wherein the volume resistivity of the static dissipative material is less than 10^9 ohm cm.
- 7. The assembly according to claim 1, the combination with Alcoe et al. showing wherein the gasket is bonded to the substrate with an adhesive **64** (see figure 3).
- 8. The assembly according to claim 7, the combination with Alcoe et al. showing wherein the adhesive is conductive.
- 10. The assembly according to claim 1, the combination with Morris show wherein the gasket **204** has a hole therein the size of the die through which the die protrudes.
- 11. The assembly according to claim 1, either reference show wherein the gasket has a shielding effectiveness to protect the die from at least 4 kV of electrostatic discharge pulse at a system level in which the assembly is to be used.
- 12. The assembly according to claim 1, either reference show wherein the gasket material has a shielding effectiveness of greater than 45 dB up to 3 GHz in frequency.
- 13. Morris (figures 1A to 4B) specifically figure 2 show an apparatus for increasing the immunity of a microprocessor form electrostatic discharge events comprising: a substrate 210; a microprocessor 212 mounted on the substrate; a heat sink 206 in heat conducting relation on a side opposite the microprocessor; a gasket of a lossy material 202 on the substrate surrounding the microprocessor to protect the microprocessor from electrostatic discharge pulses; and a thermal spreader in heat conducting relation with the microprocessor on a side of the microprocessor opposite the substrate; a heat sink 206 in heat conducting relation with the thermal spreader on a side of the thermal spreader opposite the microprocessor; wherein the thermal spreader extends beyond the outer peripheral edge of the microprocessor and overhangs an adjacent edge of the gasket.

Alcoe et al. is cited for showing an EMI shielding for semiconductor chip carriers. Specifically, Alcoe et al. (figures 1 to 3) specifically figure 2 discloses a thermal spreader (unlabeled electrically-conductive material between the heat sink 48 and chip 42 and substrate 40) in heat conducting relation with the microprocessor on a side of the microprocessor opposite the substrate; a heat sink 48 in heat conducting

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relation with the thermal spreader on a side of the thermal spreader opposite the microprocessor; wherein the thermal spreader extends beyond the outer peripheral edge of the microprocessor and overhangs an adjacent edge of the gasket (see page 3, paragragh [0040]) for the purpose of producing an EMI shield for the structure.

- 14. The apparatus according to claim 13, either reference show wherein the lossy material of the gasket is a static dissipative material having a volume resistivity of greater than 10² ohm cm.
- 15. The apparatus according to claim 14, either reference show wherein the volume resistivity of the static dissipative material is less than 10^9 ohn cm.
- 16. The apparatus according to claim 13, the combination with Alcoe et al. showing wherein the gasket is bonded to the substrate with an adhesive **64** (see figure 3).
- 17. The apparatus according to claim 13, the combination with Morris showing wherein the gasket **202** is the size of the substrate.
- 19. The apparatus according to claim 13, the combination with Morris showing wherein the gasket has a hole therein the size of the microprocessor through which the microprocessor protrudes.
- 20. The apparatus according to claim 13, the combination with Morris showing wherein tile gasket has a shielding effectiveness to protect the microprocessor from at least 4 kV of electrostatic discharge pulse at a system level In which the apparatus is to be used.
- 21. The apparatus according to claim 13, the combination with Morris showing wherein, tile gasket material has a shielding effectiveness of greater than 45 dB tip to 3 GNz in frequency.
- 23. The electronic package according to claim 22, the combination with Alcoe et al. further comprising a thermal spreader located intermediate the semiconductor die and the heat sink to thermally couple the die and heat sink.

Therefore, it would have been obvious to one of ordinary skill in the art to use Alcoe et al.'s thermal spreader to modify Morris chip to heat sink connection for the purpose of producing an EMI shield for the structure.

Claims 9 and 18 are rejected under 35 U.S.C. § 103(a) as being unpatentable over Morris (U.S. Patent # 6,507,101 B1) in view of Alcoe et al. (U.S. Patent Application Publication # 2003/0025180 A1) and further in view of Abe et al. (U.S. Patent # 5,749,586).

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Morris and Alcoe et al. show the features of the claimed invention as detailed above, but fail to explicitly show wherein the gasket is formed of expanded polytetralluoretliylene material filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10² ohm cm.

Abe et al. is cited for showing a gasket for sanitary piping. Specifically, Abe et al. (figures 1 to 3) specifically figure 1 discloses a gasket 1 is formed of expanded polytetralluoretliylene material filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10^2 ohm cm for the purpose of recovering the sealing function by repeated retightening.

Therefore, it would have been obvious to one of ordinary skill in the art to use Abe et al.'s polytetralluoretliylene gasket to modify Morris/Alcoe etal.'s gasket for the purpose of recovering the sealing function by repeated retightening.

Claims 9 and 25 are rejected under 35 U.S.C. § 103(a) as being unpatentable over Barker, III et al. (U.S. Patent # 5,175,613) in view of Abe et al. (U.S. Patent # 5,749,586).

Barker, III et al. show the features of the claimed invention as detailed above, but fail to explicitly show wherein the gasket is formed of expanded polytetralluoretliylene material filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10² ohm cm.

Abe et al. is cited for showing a gasket for sanitary piping. Specifically, Abe et al. (figures 1 to 3) specifically figure 1 discloses a gasket 1 is formed of expanded polytetralluoretliylene material filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10^2 ohm cm for the purpose of recovering the sealing function by repeated retightening.

Therefore, it would have been obvious to one of ordinary skill in the art to use Abe et al.'s polytetralluoretliylene gasket to modify Barker III, et al.'s gasket for the purpose of recovering the sealing function by repeated retightening.

Claim 25 is rejected under 35 U.S.C. § 103(a) as being unpatentable over Morris (U.S. Patent # 6,507,101 B1) in view of Abe et al. (U.S. Patent # 5,749,586).

Morris show the features of the claimed invention as detailed above, but fail to explicitly show wherein the gasket is formed of expanded polytetralluoretliylene material

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filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10² ohm cm.

Abe et al. is cited for showing a gasket for sanitary piping. Specifically, Abe et al. (figures 1 to 3) specifically figure 1 discloses a gasket 1 is formed of expanded polytetralluoretliylene material filled with a conductive material to the extent that the gasket material has a volume resistivity of greater than 10^2 ohm cm for the purpose of recovering the sealing function by repeated retightening.

Therefore, it would have been obvious to one of ordinary skill in the art to use Abe et al.'s polytetralluoretliylene gasket to modify Morris gasket for the purpose of recovering the sealing function by repeated retightening.

The listed references are cited as of interest to this application, but not applied at this time.

Field of Search	Date
U.S. Class and subclass: 257/659,660,706,700,701,712,713,177,675,676,721,790, 921	2/23/04
361/715,704,719,818	
Other Documentation:	2/23/04
foreign patents and literature in	
257/659,660,706,700,701,712,713,177,675,676,721,790,	
921	
361/715,704,719,818	
Electronic data base(s):	2/23/004
U.S. Patents EAST	

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Alexander O Williams whose telephone number is (571) 272 1924. The examiner can normally be reached on M-F 6:30-7:00PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (571) 272 1915. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

AOW 2/23/04

Alexander Williams Primary Examiner